B. Dehning CERN BE/BI

- TDI TCT settings
- Response time and maximum scale of scale of acquisition system
- TCT and TCL settings
- Start-Up procedure

TDI – TCT threshold settings



- Signal on TCT monitor over threshold during dump of beam on TDI
- Reason two fold:
 - secondary particles of TDI hit jaw of TCT and detected by downstream IC
 - secondary particles of TDI reach directly TCT IC (crosstalk)
- Actions:
 - Understanding of importance of both effects
 - Scanning of TDI, done; data analysis, to be done
 - Scanning of TCT, to be done
 - Increase threshold of TCT
 - Ratio of energy deposition in collimator and detector under investigation, BLM team
 - Increase aboard threshold (number of protons hitting collimator), collimation team

IC Saturation and Upper Limit of Acquisition Signal Chain



Pulse Response



Observation

- After single bunch impact some channels show signal decreasing to zero
- Effect due to cross talk over high voltage supply of detectors
- Effect proportional to du/dt on chamber and caused by particle signal rise/fall time
- After last years observation additional high voltage cabling (separation of IC and SEM and sectorisation of IC HV in straight sections (tuning may needed)
- Expected rise times over several turns (> 100us).
- Expected reduction of effect by 3 orders of magnitude



Electron & ion induced signal



B.Dehning

Check of BLM response in collimation areas



- Scan of collimators in IP3 (beam 1) and IP7 (beam 2)
 - IC signal:
 - all channels responded as expected
 - SEM signal:
 - Signal in the noise
 - Some channels have a to large signal; likely the detector has a vacuum leak
 - investigation are ongoing
 - Consequence: threshold settings only on ICs

Start-Up for the BLM system procedure

- Initial settings:
 - All BLM are set as mask-able, except some used for quench level calibration test and MKI ICs (settings are done in BLM system)
 - ARC test with nQPS system
 - MKI request by Brennan, thresholds to be defined by Brennan
 - All BIS BLM inputs are enabled (mask-able and un-mask-able)
- Depending of observations during low intensity running BLM channels are successively moved from the mask-able to the un-mask-able signal chain.
 - First IC
 - Later SEM
- Investigation on SEM signal observation are continued
- Electronic saturation of IC channels for single bunch loss observations
 - Installation of some more ICs on targets with a filter in the electronic chain
 - Not connected to the BIS
 - Targets are to be defined by Brennan
 - To be done in January
- Test time requests
 - Check of BLM response in IP3 for beam 2 (injected beam), 1 hour
 - Check of BLM response in IP7 for beam 1 (injected beam), 1 hour
 - Check of SEM response with (circulating beam), 1 hour
 - Quench level test with nQPS system, 4 hours